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Ryan P. Wallace **Associate**

Mr. Wallace received a Bachelor of Biomedical Engineering from the Catholic University of America in 1994 and a Master of Science in Computer Science from the Johns Hopkins University in 2000. He earned a Juris Doctor from the Georgetown University Law Center in 2007. While in law school, Mr. Wallace was a member of *The American Criminal Law Review* and co-authored an article on Computer Crimes for the *Annual Survey of White Collar Crime*.

Mr. Wallace was admitted to practice before the United States Patent and Trademark Office in 2007 and is a member of the American Bar Association, the American Intellectual Property Law Association, and the International Institute of Electrical and Electronics Engineers (IEEE). He has also been a Microsoft Certified Solution Developer since 1998.

Mr. Wallace's technical expertise includes the design and implementation of complex software applications and database systems. He worked as a consultant building client/server and web based software applications for nearly 9 years. Prior to and while attending law school, Mr. Wallace was a principal with Next Tier Concepts, Inc., a consulting company in northern Virginia, and was responsible for architecting and leading the development of many software applications for both commercial and government clients. In his final year of law school, Mr. Wallace was a law clerk at Rothwell, Figg, Ernst & Manbeck, P.C. where he worked on patent litigation, prosecution, and counseling matters.

Areas of Concentration

- Counseling
- Licensing & Transactions
- Litigation
- Copyright
- Patent Prosecution
 - Electrical & Computers
 - Mechanical
 - Software, E-Commerce, & Business Methods

Education:

- B.B.E. (Biomedical Engineering) from the Catholic University of America, 1994
- M.S. Computer Science from the Johns Hopkins University, 2000
- J.D. from the Georgetown University Law Center, 2007

Bar Admissions:

- U.S. Patent and Trademark Office